

Notice of References Cited	Application/Control No. 10/540,023	Applicant(s)/Patent Under Reexamination OHISHI ET AL.	
	Examiner Jason M. Nolan, Ph.D.	Art Unit 1626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,122,526	06-1992	Wall et al.	514/253.02
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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